

**Search Notes**

Application/Control No.

10/713,210

Examiner

John Q. Nguyen

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

3654

**SEARCHED**

| Class                      | Subclass | Date    | Examiner |
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| Previous search<br>updated |          | 8/11/05 | JN       |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

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